Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 129219		APPLICATION NO. 10/590,973			
INFORMATION DISCLOSURE STATEMENT									
(Use several sheets if necessary)				APPLICANT(S) Ali LAAYOUN et al.					
				FILING DATE August 28, 2006			GROUP 1626		
U.S. PATENT DOCUMENTS									
Examiner Initials	Cite No.	Document Number	Da	te Name					
	1.	4,775,745	10/04/1988		Ford et al.				
	2.	5,489,653	02/06/1996		Charles et al.				
	3.	5,695,936	12/09/1997		Mandrand et al.				
	4.	6,033,853	03/07/2000		Delair et al.				
	5.	6,133,047	10/17/2000		Elaissari et al.				
	6.	6,376,179 B1	04/23/2002		Laayoun				
	7.	6,489,114 B2	12/03/2002		Laayoun et al.				
	8.	6,521,341 B1	02/18/2003		Elaissari et al.				
	9.	6,537,783 B1	03/25/2003		Guillou-Bonnici et al.				
	10.	6,632,662 B1	10/14/2003		Broyer et al.				
	11.	6,660,472 B1	12/09/2003		Santoro et al.				
	12.	6,686,195 B1	02/03/2004		Colin et al.				
	13.	6,818,398 B2	11/16/2004		Bavykin et al.				
	14.	6,875,858 B1	04/05/2005		DeFrancq et al.				
	15.	2002/0081586 A1	06/27/2002		Laayoun et al.				
	16.	2002/0155496 A1	10/24/2002		Charles et al.				
	17.	2004/0005614 A1	01/08/2004		Kum et al.				
	18.	2004/0091451 A1	05/13/2004		Charreyre et al.				
	19.	2008/0032288 A1	02/07/2008		Laayoun et al.				
FOREIGN PATENT DOCUMENTS									
Examiner Initials	Cite No.	Document Number	Da	ite	Country		With English Abstract	With English Translation	
	20.	EP 0 201 184 A2	12/17/19	986	Europe				
	21.	WO 90/08838 A1	08/09/19	990	WIPO				
	22.	WO 97/35031 A1	09/25/19	97	WIPO		X		
	23.	WO 2005/092910 A1	10/06/20	005	WIPO		Х		
EXAMINER						DATE CONSIDERED			
Examiner:		citation considered, whether or not citation considered. Include copy of this form with				through cit	ation if not in	conformance	

Date: December 31, 2009

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			FILING DATE August 28, 2006	GROUP 1626						
OTHER DOCUMENTS										
Examiner Initials	Cite No.	Including name of the author (in CAPITAL LET journal, serial, symposium, catalog, etc.), date, pa	TERS), title of the article (when appropriate), title of the item (book, magazine, age(s), volume-issue number(s), publisher, city and/or country where published.							
	24. G. M. Makrigiorgos et al., "Fluorescent Labeling of Abasic Sites: A Novel Methodology to Detect Closely-Spaced Damage									
		in DNA," Int. J. Radiat. Biol. (1998), Vol. 74, No. 1, pp. 99-109.								
	25.	W. C. Still et al., "Rapid Chromatographic Technique for Preparative Separations with Moderate Resolution," J. Org. Chem. (1978), Vol. 43, No. 14, pp. 2923-2925.								
	26.	A. Troesch et al., "Mycobacterium Species Identification and Rifampin Resistance Testing with High-Density DNA Pro								
		Arrays," Journal of Clinical Microbiology (Jan. 1	990), Vol. 37, No. 1, pp. 49-55.							
	27.	July 25, 2002 International Search Report issued in International Application No. PCT/FR02/01543.								
	28.	January 14, 2009 International Search Report issu	ued in International Application No. PCT/F	R2008/051026.						
	29.	July 30, 2004 Office Action issued in U.S. Patent Application No. 10/137,454, now U.S. Patent No. 7,338,805 B2.								
:	30.	February 23, 2005 Office Action issued in U.S. Patent Application No. 10/137,454, now U.S. Patent No. 7,338,805 B2.								
-		11 11 2005 OF A 12 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2								
	July 11, 2005 Office Action issued in U.S. Patent Application No. 10/137,454, now U.S. Patent No. 7,338,805 B2.									
	32.	February 6, 2006 Office Action issued in U.S. Patent Application No. 10/137,454, now U.S. Patent No. 7,338,805 B2.								
	33.	March 29, 2007 Office Action issued in U.S. Patent Application No. 10/137,454, now U.S. Patent No. 7,338,805 B2.								
	34.	March 18, 2005 Office Action issued in U.S. Patent Application No. 10/137,460, now U.S. Patent No. 7,060,441 B2.								
EXAMINER				DATE CONSIDERED						
Examiner:		citation considered, whether or not citation is in co		through citation if not in conformance						

Date: December 31, 2009